

Form PTO-1449 (Modified)	U.S. Department of Commerce Patent and Trademark Office	Atty. Docket No. 20103/030294	Serial No. 10/829,539
INFORMATION DISCLOSURE STATEMENT <i>(Use several sheets if necessary)</i>		Applicants Taylor et al.	
		Filing Date 2004-04-22	Group Art Unit 2419

U.S. PATENT DOCUMENTS							
*EXAMINER INITIALS	CITE NO.	DOCUMENT NUMBER	ISSUE DATE	INVENTOR(S)	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE
	1.	4905233	1990-02-27	Cain et al.			
	2.	5016244	1991-05-14	Massey, Jr. et al.			
	3.	5408461	1995-04-18	Uriu et al.			
	4.	5544170	1996-08-06	Kasahara, Hiroyuki			
	5.	5548639	1996-08-20	Ogura et al.			
	6.	5559959	1996-09-24	Foglar, Andreas			
	7.	5633859	1997-05-27	Jain et al.			
	8.	5650994	1997-07-22	Daley, Kathleen			
	9.	5856981	1999-01-05	Voelker, John Alvan			
	10.	5894475	1999-04-13	Bruno et al.			
	11.	5936939	1999-08-10	Des Jardins et al.			
	12.	6028863	2000-02-22	Sagawa et al.			
	13.	6038219	2000-03-14	Mawhinney et al.			
	14.	6108300	2000-08-22	Coile et al.			
	15.	6108307	2000-08-22	McConnell et al.			
	16.	6167025	2000-12-26	Hsing et al.			
	17.	6181675	2001-01-30	Miyamoto, Akihiro			
	18.	6181679	2001-01-30	Ashton et al.			
	19.	6185695	2001-02-06	Murphy et al.			
	20.	6195416	2001-02-27	DeCaluwe et al.			

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*EXAMINER INITIALS	CITE NO.	DOCUMENT NUMBER	ISSUE DATE	INVENTOR(S)	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE
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	22.	6311288	2001-10-30	Heeren et al.			
	23.	6377548	2002-04-23	Chuah, Mooi Choo			
	24.	6424629	2002-07-23	Rubino et al.			
	25.	6456306	2002-09-24	Chin et al.			
	26.	6473398	2002-10-29	Wall et al.			
	27.	6538987	2003-03-25	Cedrone et al.			
	28.	6553015	2003-04-22	Sato, Hiroyuki			
	29.	6556659	2003-04-29	Bowman-Amuah, Michel K.			
	30.	6570846	2003-05-27	Ryoo, In-Tae			
	31.	6581166	2003-06-17	Hirst et al.			
	32.	6590899	2003-07-08	Thomas et al.			
	33.	6594268	2003-07-15	Aukia et al.			
	34.	6643254	2003-11-04	Kajitani et al.			
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	36.	6763476	2004-07-13	Dangi et al.			
	37.	6766113	2004-07-20	Al-Salameh et al.			
	38.	6781952	2004-08-24	Shirakawa, Toshikuni			
	39.	6795394	2004-09-21	Swinkels et al.			
	40.	6823477	2004-11-23	Cheng et al.			
	41.	6826184	2004-11-30	Bryenton et al.			
	42.	6829223	2004-12-07	Richardson et al.			
	43.	6862351	2005-03-01	Taylor, William Scott			
	44.	6865170	2005-03-08	Zendle, Allan M.			
	45.	6925578	2005-08-02	Lam et al.			
	46.	6952395	2005-10-04	Manoharan et al.			
	47.	6973034	2005-12-06	Natarajan et al.			
	48.	6981039	2005-12-27	Cerami et al.			

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	49.	6983401	2006-01-03	Taylor, William Scott			
	50.	6990616	2006-01-24	Botton-Dascal et al.			
	51.	7027053	2006-04-11	Berndt et al.			
	52.	7093155	2006-08-15	Aoki, Makoto			
	53.	7120148	2006-10-10	Batz et al.			
	54.	7120819	2006-10-10	Gurer et al.			
	55.	7165192	2007-01-16	Cadieux et al.			
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	58.	7240364	2007-07-03	Branscomb et al.			
	59.	7275192	2007-09-25	Taylor et al.			
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*EXAMINER INITIALS	CITE NO.	DOCUMENT NUMBER	ISSUE DATE	INVENTOR(S)	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE
	1.	20010000700	2001-05-03	Eslambolchi et al.			
	2.	20020001307	2002-01-03	Nguyen et al.			
	3.	20020072358	2002-06-13	Schneider et al.			
	4.	20020089985	2002-07-11	Wahl et al.			
	5.	20030043753	2003-03-06	Nelson et al.			
	6.	20030051195	2003-03-13	Bosa et al.			
	7.	20030091024	2003-05-15	Stumer, Peggy M.			
	8.	20030128692	2003-07-10	Mitsumori et al.			
	9.	20040090973	2004-05-13	Christie et al.			
	10.	20040125776	2004-07-01	Haugli et al.			

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	11.	20040141464	2004-07-22	Taylor et al.			
	12.	20040172574	2004-09-02	Wing et al.			
	13.	20050013242	2005-01-20	Chen et al.			
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	22.	20050237925	2005-10-27	Taylor et al.			
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*Examiner Initials	Cite No.	Document Number	Publication Date	Country	Class	Subclass	Translation	
							Yes	No
	1.							

OTHER DOCUMENTS (Including Author, Title, Date, Pertinent Pages, etc.)		
1.	Don Ryan, The Telco Handbook For New Technicians – An Introduction To Telco Technology And Troubleshooting, October 27, 2000, [retrieved from http://www.darkwing.net/aaron/telco.doc , accessed on November 11, 2006], 67 pages.	

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